

Search Notes

Application/Control No.

10/537,817

Examiner

Kien T. Nguyen

Applicant(s)/Patent under
Reexamination

UENO ET AL.

Art Unit

3711

SEARCHED

Class	Subclass	Date	Examiner
446	¹ 308-312	8/7/2006	KN
472	54	8/7/2006	KN
273	⁴⁵⁹ 138.2	8/7/2006	KN
273	⁴⁴⁰ ⁴⁴⁵ 446	8/7/2006	KN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR